(12) INTERNATIONAL APPLICATION PUBLISHED UNDER THE PATENT COOPERATION TREATY (PCT)

(19) World Intellectual Property Organization

International Bureau



(43) International Publication Date 10 June 2004 (10.06.2004)

PCT

(10) International Publication Number WO 2004/048886 A1

(51) International Patent Classification7: G01B 9/02, 11/30

(21) International Application Number:

PCT/GB2003/005080

(22) International Filing Date:

21 November 2003 (21.11.2003)

(25) Filing Language:

English

(26) Publication Language:

English

(30) Priority Data:

0227673.1

27 November 2002 (27.11.2002)

(71) Applicant (for all designated States except US): TAYLOR HOBSON LIMITED [GB/GB]; 2 New Star Road, Leicester LE4 9JQ (GB).

(72) Inventors; and

(75) Inventors/Applicants (for US only): BANKHEAD,

Andrew, Douglas [GB/GB]; c/o Taylor Hobson Limited, 2 New Star Road, Leicester LE4 9JQ (GB). LEE-BEN-NETT, Ian [GB/GB]; c/o Taylor Hobson Limited, 2 New Star Road, Leicester LE4 9JQ (GB). MCDONNELL, Ivor [GB/GB]; c/o Taylor Hobson Limited, 2 New Star Road, Leicester LE4 9JQ (GB).

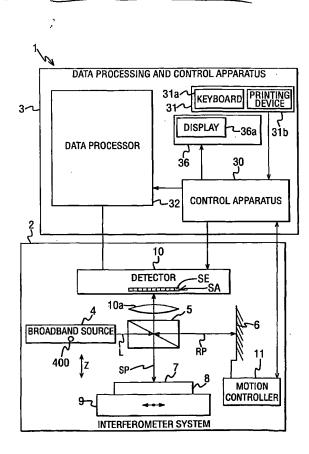
(74) Agents: BERESFORD, Keith, Denis, Lewis et al.; Beresford & Co., 16 High Holborn, London WC1V 6BX (GB).

(81) Designated States (national): AE, AG, AL, AM, AT, AU, AZ, BA, BB, BG, BR, BW, BY, BZ, CA, CH, CN, CO, CR, CU, CZ, DE, DK, DM, DZ, EC, EE, EG, ES, FI, GB, GD, GE, GH, GM, HR, HU, ID, IL, IN, IS, JP, KE, KG, KP, KR, KZ, LC, LK, LR, LS, LT, LU, LV, MA, MD, MG, MK, MN, MW, MX, MZ, NI, NO, NZ, OM, PG, PH, PL, PT, RO, RU, SC, SD, SE, SG, SK, SL, SY, TJ, TM, TN, TR, TT, TZ, UA, UG, US, UZ, VC, VN, YU, ZA, ZM, ZW.

(84) Designated States (regional): ARIPO patent (BW, GH, GM, KE, LS, MW, MZ, SD, SL, SZ, TZ, UG, ZM, ZW),

[Continued on next page]

(54) Title: A SURFACE PROFILING APPARATUS



(57) Abstract: Light is directed along a sample path towards the sample surface and along a reference path towards a reference surface such that light reflected by the sample surface and light reflected by the reference surface interfere. Relative movement is effected between the sample surface and the reference surface along a measurement path and the light intensity resulting from interference between light reflected from the reference surface and regions of the sample surface is sensed at intervals along the measurement path to provide a number of sets of light intensity data values with each light intensity data value representing the sensed light intensity associated with a corresponding one of said regions. The sets of light intensity data are processed to determine a position along the measurement path at which a predetermined feature occurs in the light intensity data for each sensed region and to enhance image data representing the intensity data to facilitate the detection by a user of the interference fringes.



WO 2004/048886 A1



Eurasian patent (AM, AZ, BY, KG, KZ, MD, RU, TJ, TM), European patent (AT, BE, BG, CH, CY, CZ, DE, DK, EE, ES, FI, FR, GB, GR, HU, IE, IT, LU, MC, NL, PT, RO, SE, SI, SK, TR), OAPI patent (BF, BJ, CF, CG, CI, CM, GA, GN, GQ, GW, ML, MR, NE, SN, TD, TG).

For two-letter codes and other abbreviations, refer to the "Guidance Notes on Codes and Abbreviations" appearing at the beginning of each regular issue of the PCT Gazette.

Published:

with international search report